


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/626,787	LEEK, WILLIAM F.	
	Examiner	Art Unit	
	PHI D. A	3633	

ISSUE CLASSIFICATION											
ORIGINAL					CROSS REFERENCE(S)						
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
52		223.1			52	223.13	223.14	293.3	296	298	
INTERNATIONAL CLASSIFICATION					411	231	917				
E	0	2	D	5/74	74	441					
E	0	4	D	5/76							
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(Assistant Examiner) (Date)					/Phi D. A/ 9/25/08					Total Claims Allowed: 19	
(Legal Instruments Examiner) (Date)					PHI DIEU TRAN A					O.G. Print Claim(s)	O.G. Print Fig.
										1	4A
					(Primary Examiner) (Date)						

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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